

2013年度NIFS画像計測研究会

マイクロTexonにおけるパラメトリック確率 モデルおよび画像理解への応用

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統計解析手法

- (1) 主成分分析
- (2) 独立成分分析
- (3) 多様体学習 (LLE, LPP等)
- (4) Sparse Coding

拡張

- ① 非線形 (kernel関数)
- ② テンソルベース (多重線形) 統計解析

Deep Learning

超解像度技術
画質改善

機械学習・統計
解析

画像認識・理解

医用画像処理
医療診断支援

- (1) 肝硬変診断支援;
- (2) 医用画像検索による医療疾患診断支援
- (3) 医用データの画質改善、エッジ抽出
- (4) 学習ベース医用画像超解像度

目的: 画像認識・理解

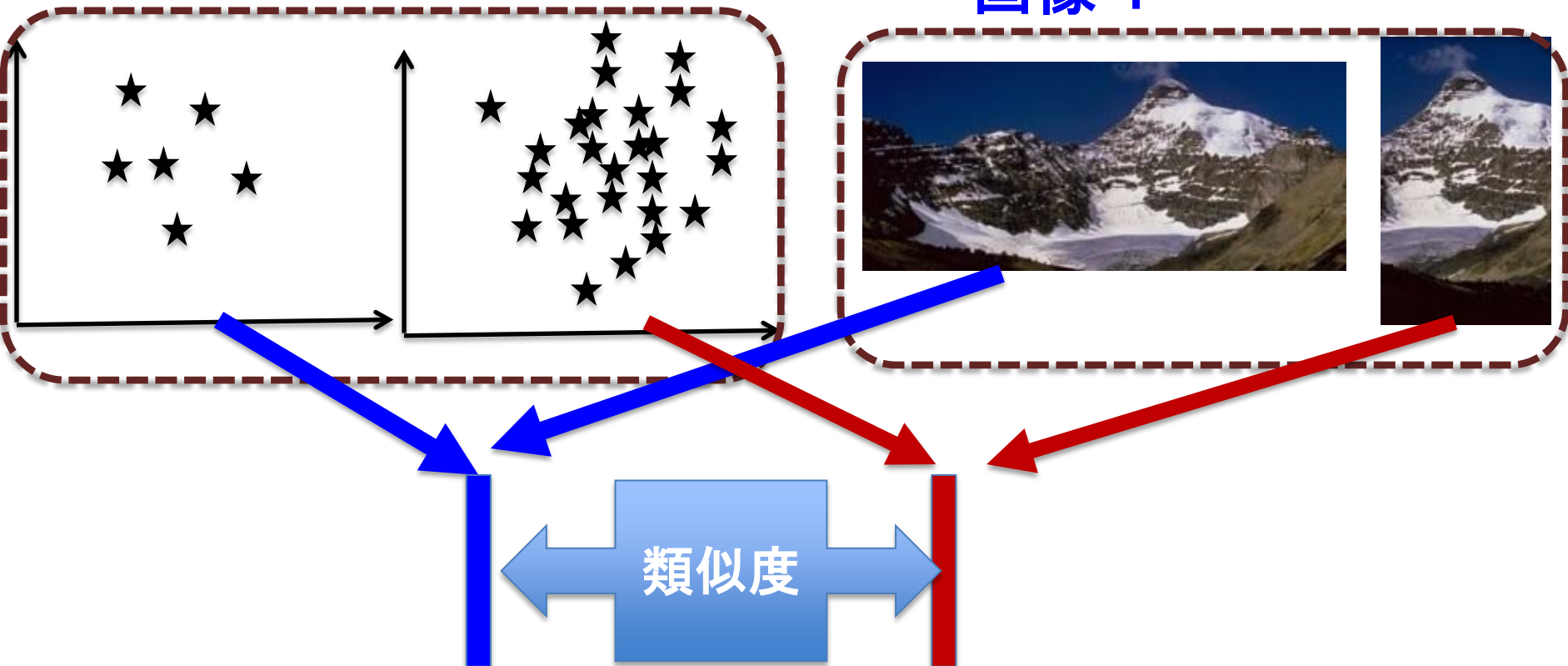
データの集約
コア情報の抽出

Data 1

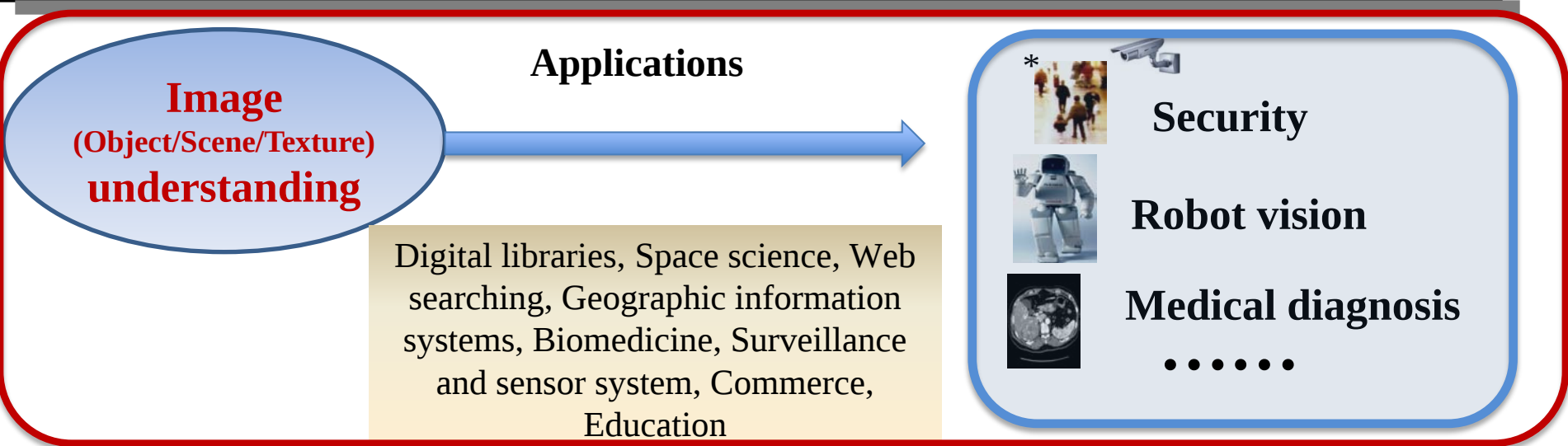
Data 2

画像 1

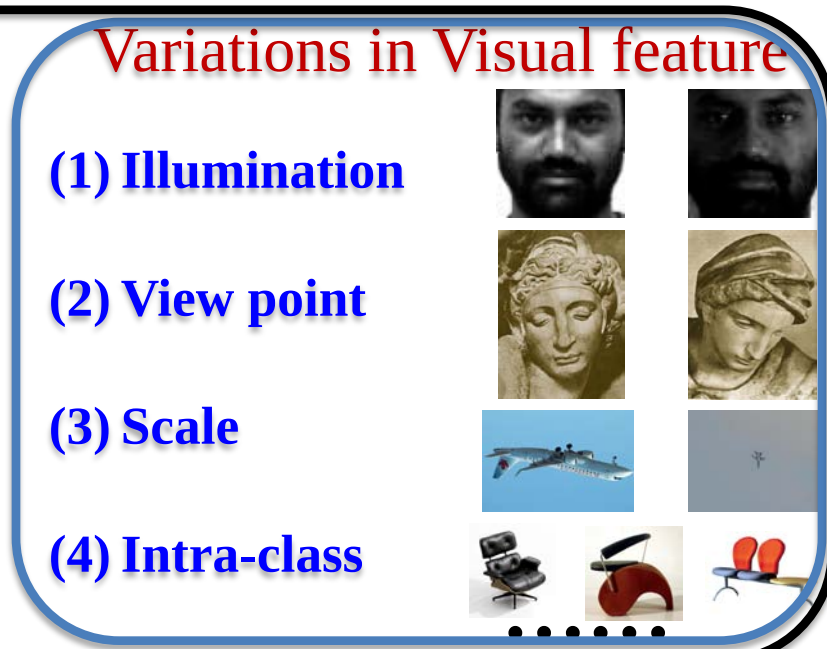
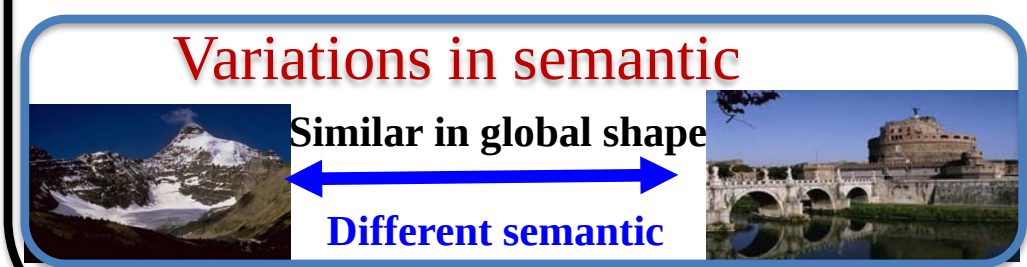
画像 2

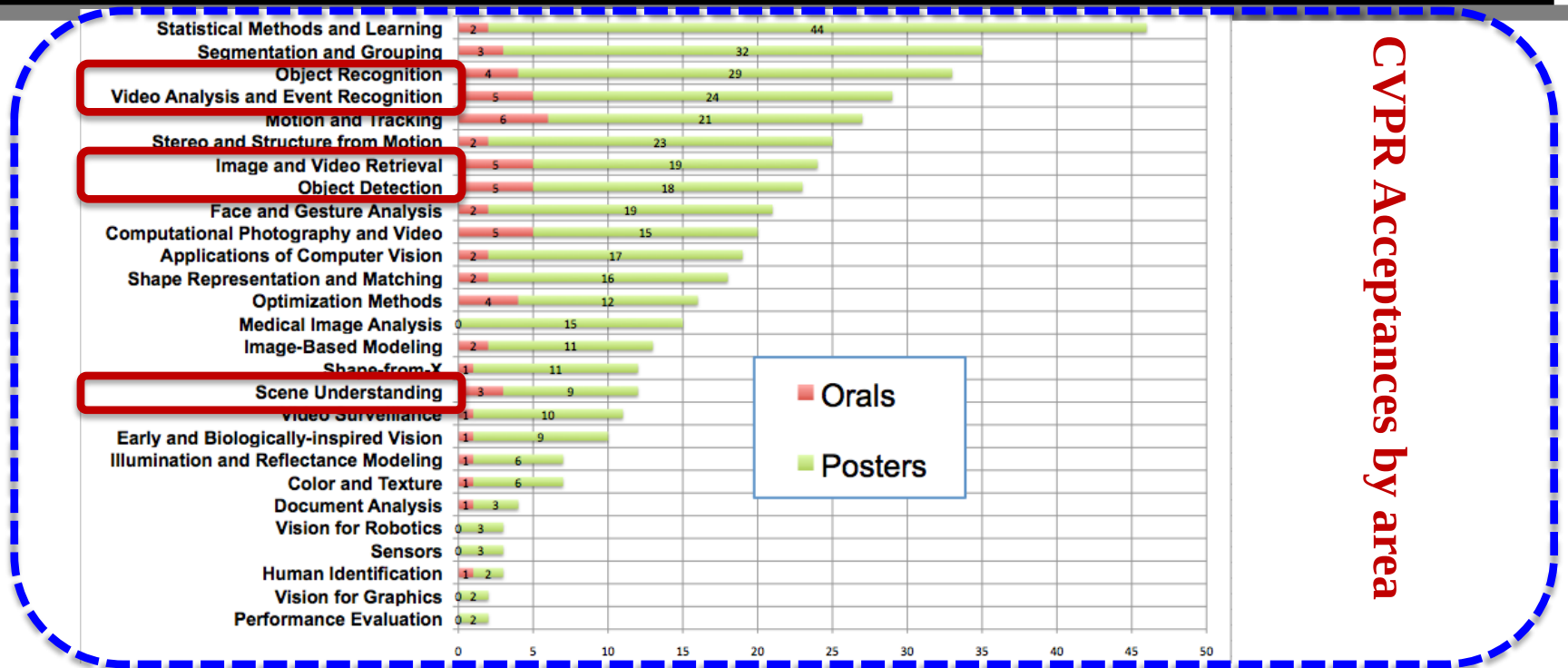


- Introduction
- Related Works
- Micro-Texton space for local structure representation
- Parametric probability model and high-order statistics
- Experimental Results
 - HEp-2 Cell pattern recognition
 - Food image classification
 - Texture classification
- Conclusions

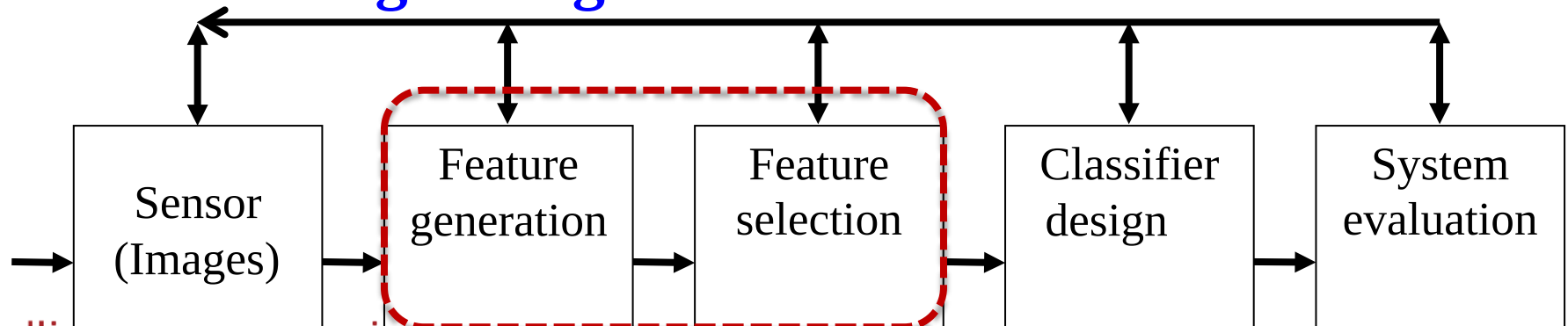


- **Difficulties**
 - Variable & uncontrolled image conditions
 - Complex and hard-to-describe objects in image
 - Objects occluding other objects

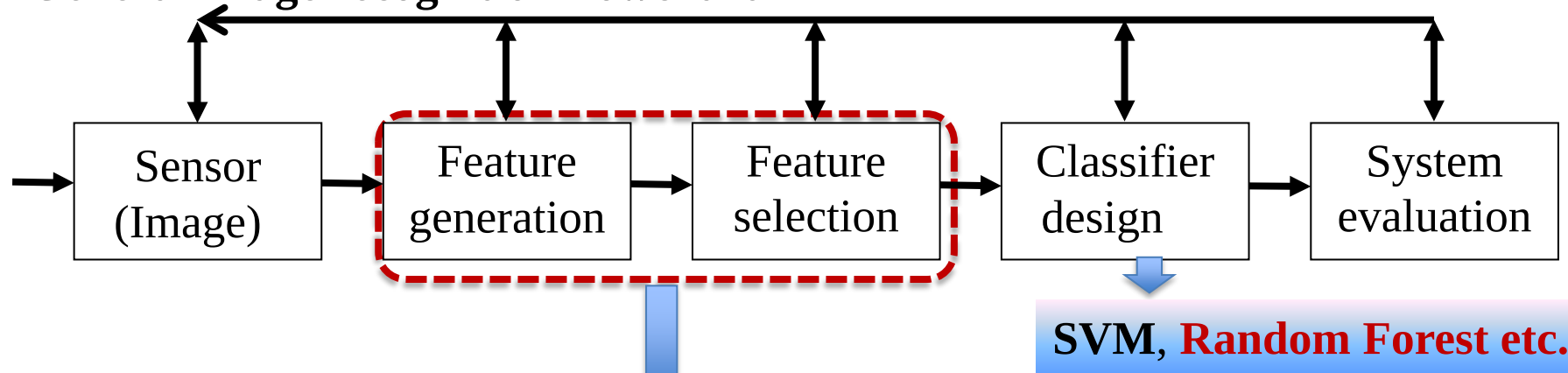




General image recognition flowchart



General image recognition flowchart



Feature Generation

- (1) Global features:
 - A. Intensity-based feature (Alignment)
 - B. Color information (histogram, Moment)
 - C. Shape information (edge histogram, HOG)
 - D. Texture information (Gist)

- (2) Local binary pattern
Local descriptor (SIFT)

Feature Selection

Subspace learning (PCA, ICA)
Manifold learning (LPP, Isomap)
Discriminant analysis (LDA)
.....

Pattern Histogram
Bag-of-Feature (BOF)

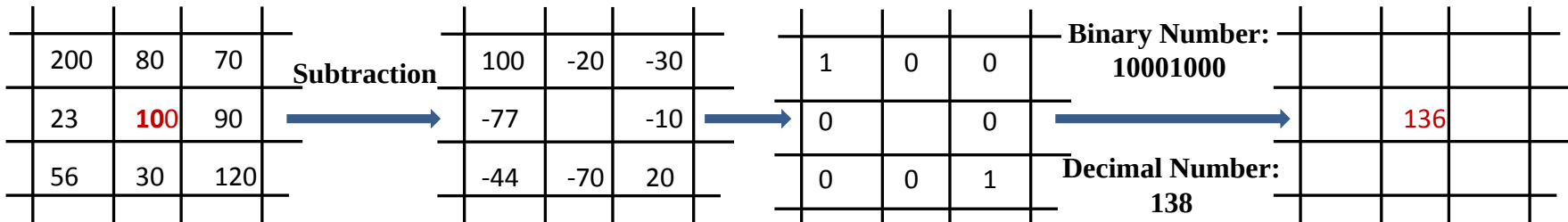
**Popular & Reasonable
performance**

(2) Local binary pattern

Integration

Pattern Histogram

LBP value



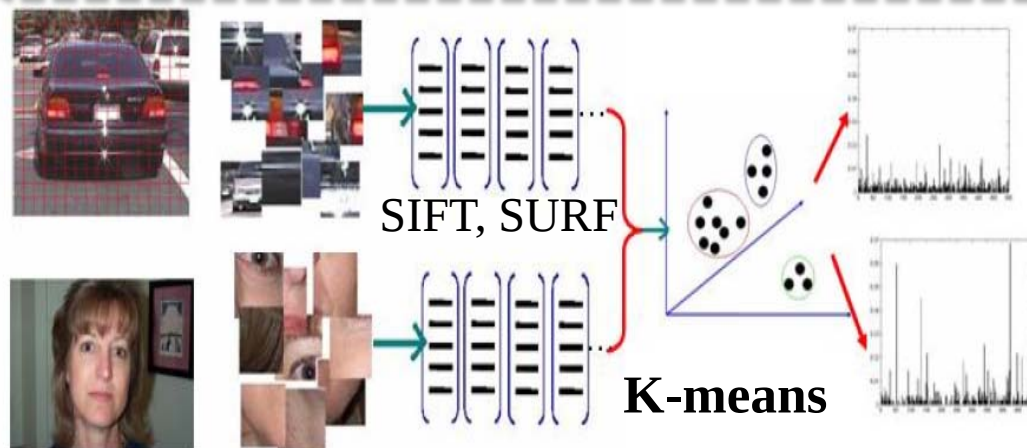
Drawbacks:

- (1) **Information lost:** only quantizing the differential vector into binary
- (2) **Only low-order statistics**

Local descriptors (SIFT, SURF)

Integration

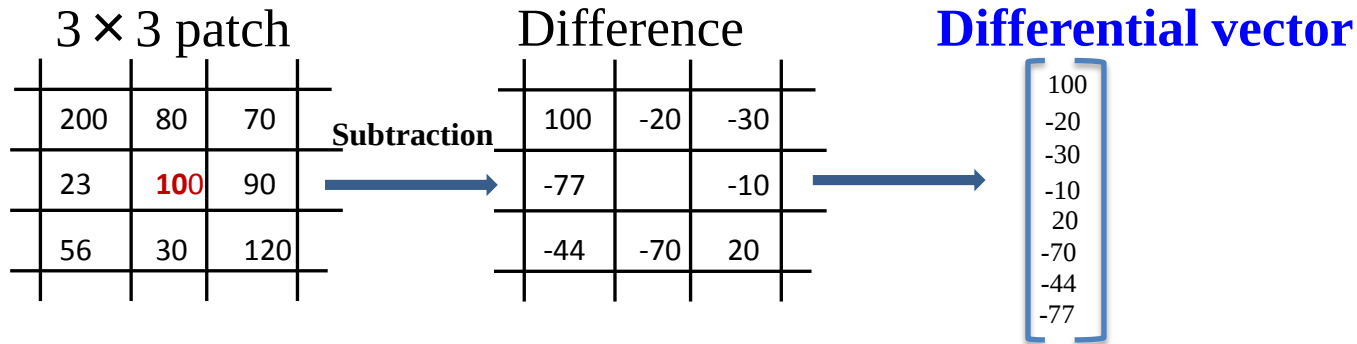
Bag-of-Feature (BOF)



Drawbacks:

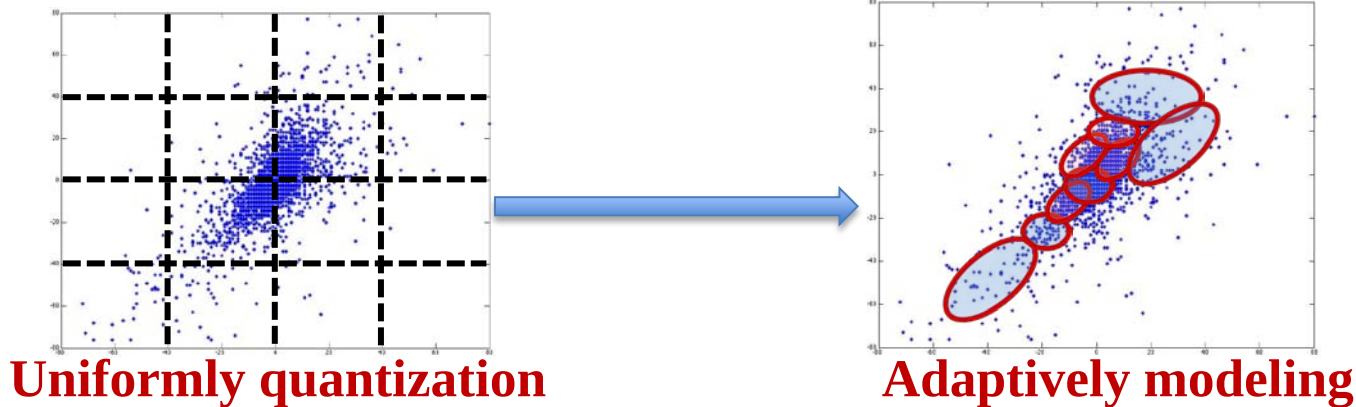
- (1) **Time-Consuming:**
local descriptor extraction
Enough number visual words
- (2) **Information lost:**
Approximation each local descriptors
with the pre-defined visual words
- (3) **Only Low-order statistics**

(1) Directly use the differential vector as local descriptor, called **micro-Texton**



(2) Model the micro-Texton using a parametric probability process: GMM

A simple example

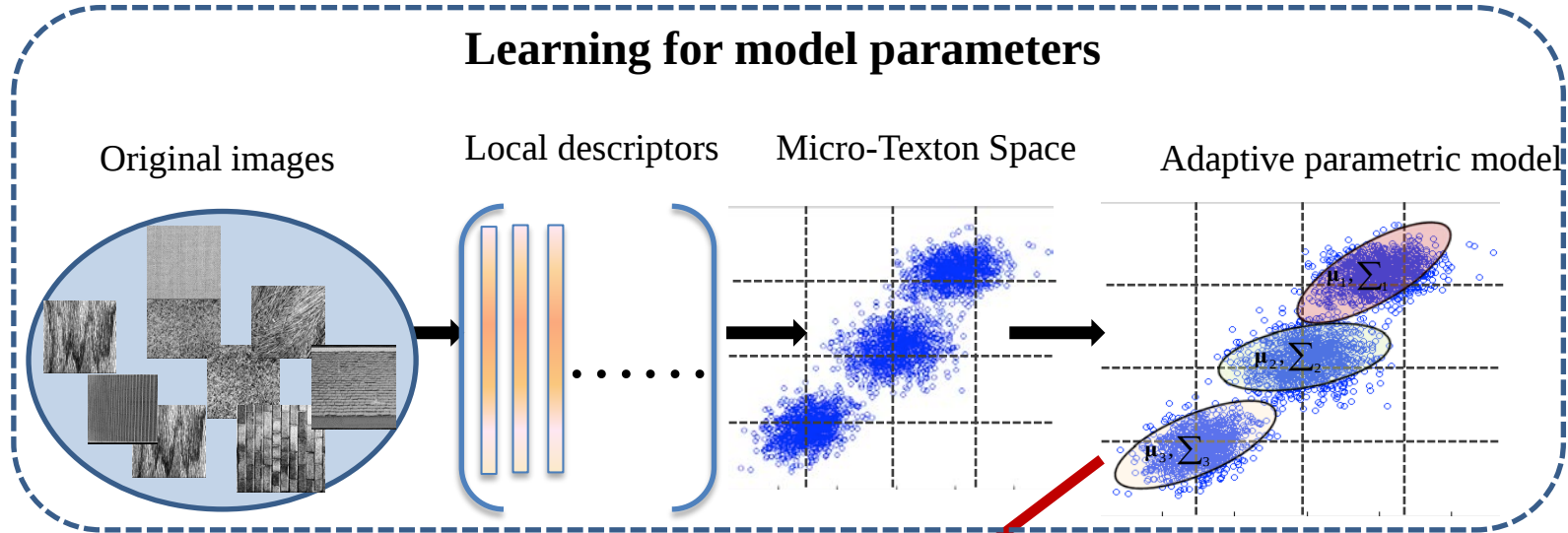


Assign a local descriptor to several models (not only one like in BOF)

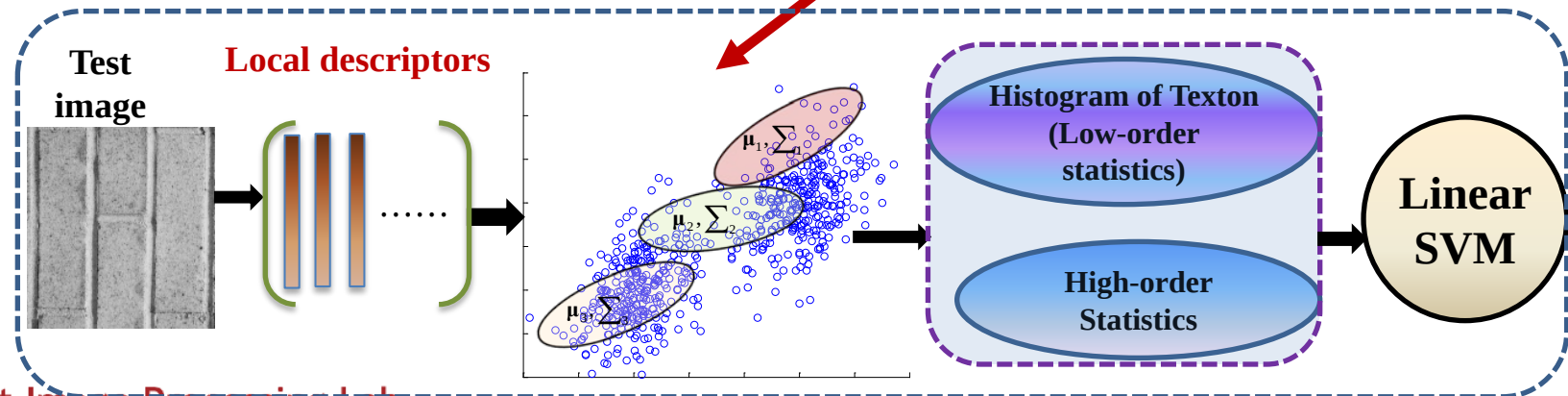
(3) Extract not only low-order statistics but also high-order statistics for image representation

Flowchart of the Proposed strategy

Training Procedure



Test Procedure



Proposed Strategy: Adaptively modeling micro-Texton



Given some local descriptors (micro-Texton) $\mathbf{X}$ extracted from Training images, **we model them using the parametric probability process: GMM**

$$P(\mathbf{X}/\lambda) = \sum_{k=1}^K w_k N(\mathbf{X}/\mu_k, \Sigma_k)$$

$$= \sum_{k=1}^K w_k \frac{1}{(2\pi)^{\frac{D}{2}} |\Sigma_k|^{\frac{1}{2}}} \exp\left\{-\frac{1}{2}(\mathbf{X} - \mu_k)^T \Sigma_k^{-1} (\mathbf{X} - \mu_k)\right\}$$

Unknown parameters:
Need to learn using the micro-Texton ensemble $\mathbf{X}$

Expectation maximization (EM) method: With initial parameters:

(1) Expectation Step: compute the responsibilities (posterior probability for each Texton samples):

$$\gamma_{t,k} = \frac{w_k P(k/\mathbf{x}_t, \lambda)}{\sum_{k=1}^K w_k P(k/\mathbf{x}_t, \lambda)}$$

(2) Maximization Step: compute the weighted means, variances and mixture weights:

$$\mu_k = \frac{\sum_{t=1}^T \gamma_{t,k} \mathbf{x}_t}{\sum_{t=1}^T \gamma_{t,k}} \quad \Sigma_k = \frac{\sum_{t=1}^T \gamma_{t,k} \mathbf{x}_t^2}{\sum_{t=1}^T \gamma_{t,k}} - \mu_k^2 \quad w_k = \frac{1}{T} \sum_{t=1}^T \gamma_{t,k}$$

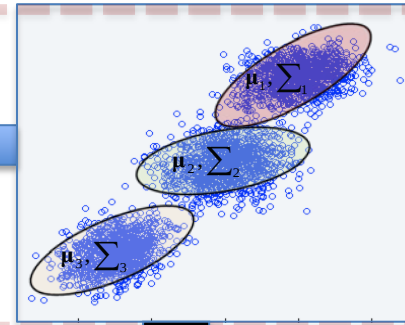
Proposed Strategy: statistics (low and high orders)



Known model parameters

$$\{w_k, \mu_k, \Sigma_k, k = 1, \dots, K\}$$

Constructed model
using training
database



Only use diagonal
elements

$$w_k = \frac{\exp(\alpha_k)}{\sum_{j=1}^K \exp(\alpha_j)}$$

$$\sigma_k = \text{diag}(\Sigma_k)$$

Given the local descriptors (micro-Textons) $\mathbf{X}=[\mathbf{x}_1, \mathbf{x}_2, \dots, \mathbf{x}_T]$ extracted from a test image, **our goal is to extract discriminant feature for image representation:**

The deviation
statistics of $\mathbf{X}$
to the learned
parameters

Mathematical definition: $\mathbf{G}_\lambda^{\mathbf{X}} = \nabla_\lambda \log P_\lambda(\mathbf{X})$

Computational implementation:

$$\frac{\partial P(\mathbf{X}|\lambda)}{\partial \alpha_k} = \sum_{t=1}^T [\gamma_t(k) - w_k]$$

$$\frac{\partial P(\mathbf{X}|\lambda)}{\partial \mu_k^d} = \sum_{t=1}^T \gamma_t(k) \left[\frac{x_t^d - \mu_k^d}{(\sigma_k^d)^2} \right]$$

$$\frac{\partial P(\mathbf{X}|\lambda)}{\partial \sigma_k^d} = \sum_{t=1}^T \gamma_t(k) \left[\frac{(x_t^d - \mu_k^d)^2}{(\sigma_k^d)^3} - \frac{1}{\sigma_k^d} \right]$$

Proposed Strategy: statistics (low and high orders)



Given the local descriptors (micro-Textons) $\mathbf{X}=[\mathbf{x}_1, \mathbf{x}_2, \dots, \mathbf{x}_T]$ extracted from a test image, **our goal is to extract discriminant feature for image representation:**

Computational implementation:

The deviation statistic to w_k :
$$\frac{\partial P(\mathbf{X}|\lambda)}{\partial \alpha_k} = \sum_{t=1}^T [\gamma_t(k) - w_k]$$

Similar to histogram of texton in an image (like in BOF)
Called **0th order statistics** (low-order statistics)

The deviation statistic to μ_k, Σ_k

$$\frac{\partial P(\mathbf{X}|\lambda)}{\partial \mu_k^d} = \sum_{t=1}^T \gamma_t(k) \left[\frac{x_t^d - \mu_k^d}{(\sigma_k^d)^2} \right]$$

$$\frac{\partial P(\mathbf{X}|\lambda)}{\partial \sigma_k^d} = \sum_{t=1}^T \gamma_t(k) \left[\frac{(x_t^d - \mu_k^d)^2}{(\sigma_k^d)^3} - \frac{1}{\sigma_k^d} \right]$$

The **first and second order statistics**
(high-order statistics)

The
deviation
statistics of
 $\mathbf{X}$ to the
learned
parameters

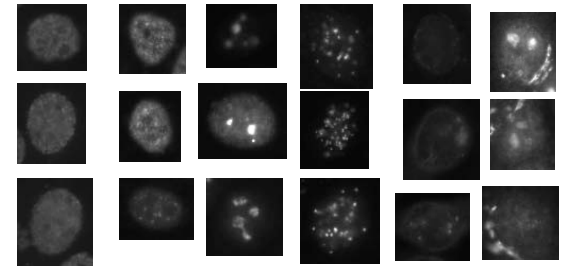
Three different Databases

(1) HEP-2 Cell database (ICIP2013 competition on cell classification by fluorescent image analysis):

(1) Two intensity Type: Positive and intermediate

(2) More than 10000 images

(3) 6 cell patterns for each intensity type



(2) Food image datasets (Pittsburgh fast-food image dataset: PFID): large-pose variance

(a) 61 categories

(b) 3 instances (6 different pose images) for each category



(3) Texture dataset (TIPS-2a): Large scale and pose variance

(a) 11 texture types (different materials);

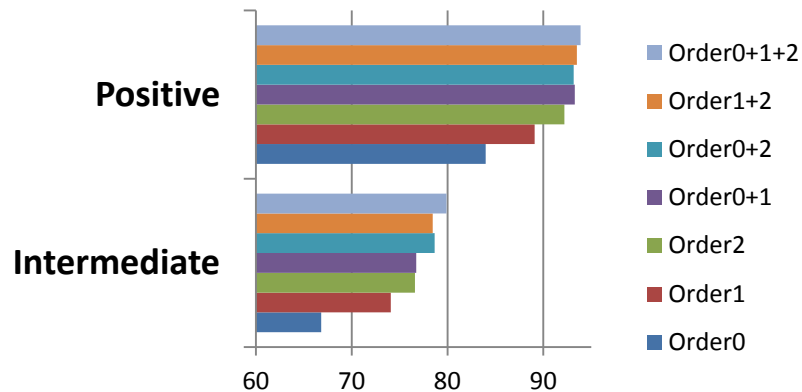
(b) 4 samples (with different rotated and scaled images) for each texture type



(1) Classifier: Linear SVM; (2) Randomly select 600 images (about a half) from each pattern for training; the remainder for test . The average recognition rates of 10 runs:

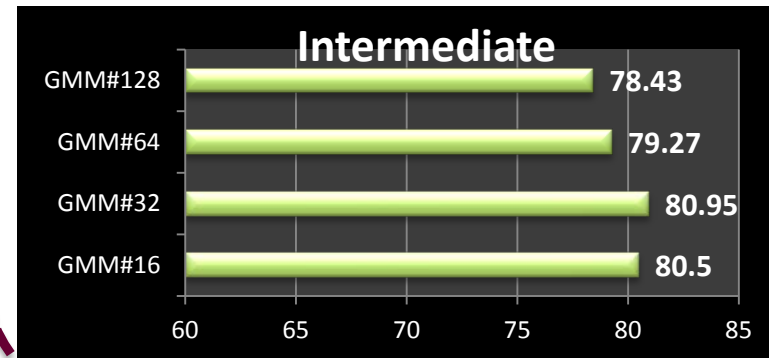
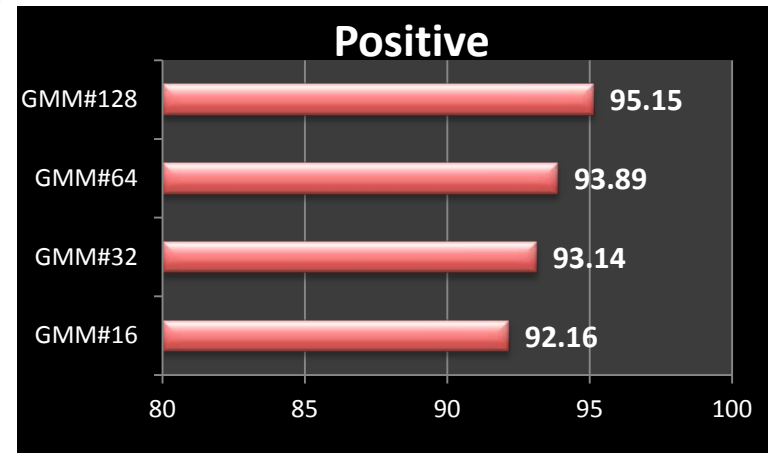
	Positive	Intermediate
LBP	58.87 ± 1.2	37.49 ± 1.78
Our	93.89 ± 0.42	79.89 ± 0.43

Compared with LBP histogram (64 Gaussian components: all order statistics)



Comparison with different order statistics

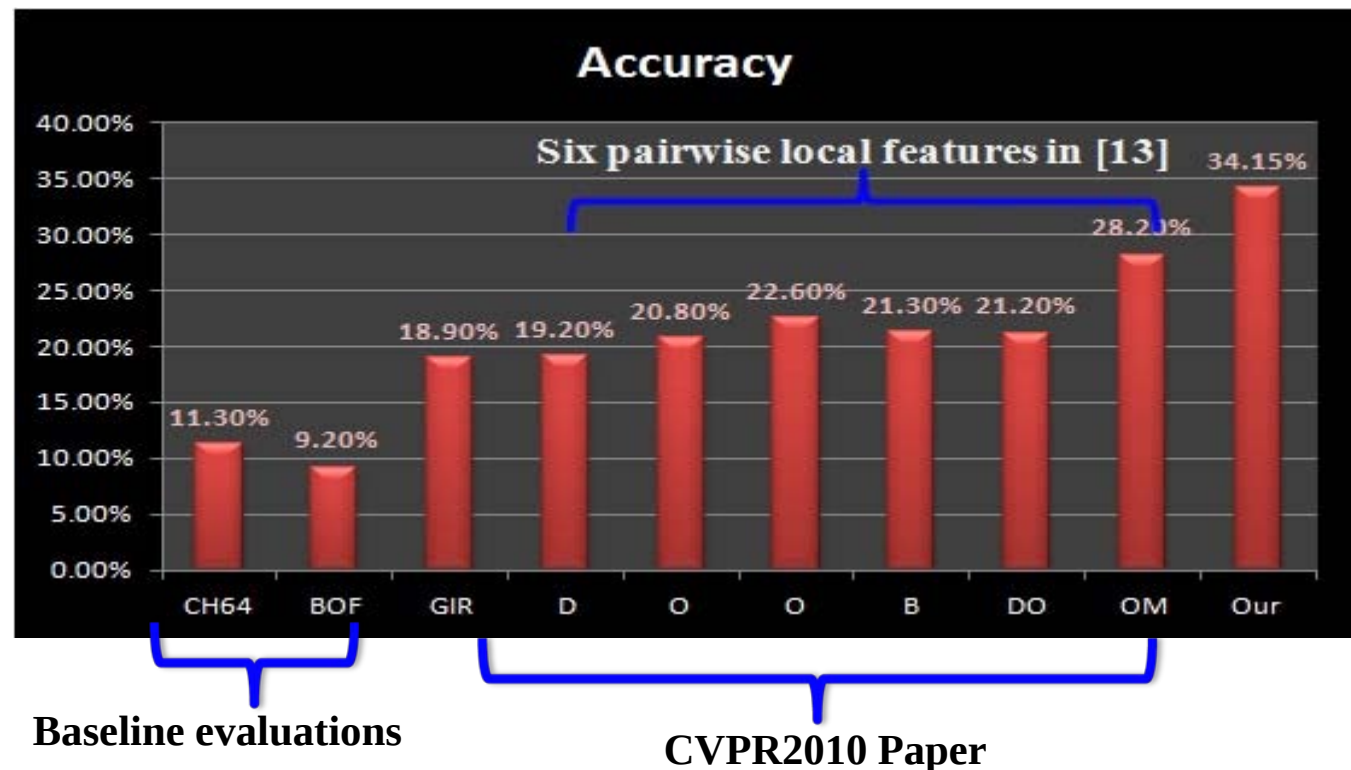
Compared results with different component numbers



- (1) Classifier: linear SVM
- (2) Select the images of two instances for training, and the remainder one for test (same to the experimental setting in the state-of-the-art methods)

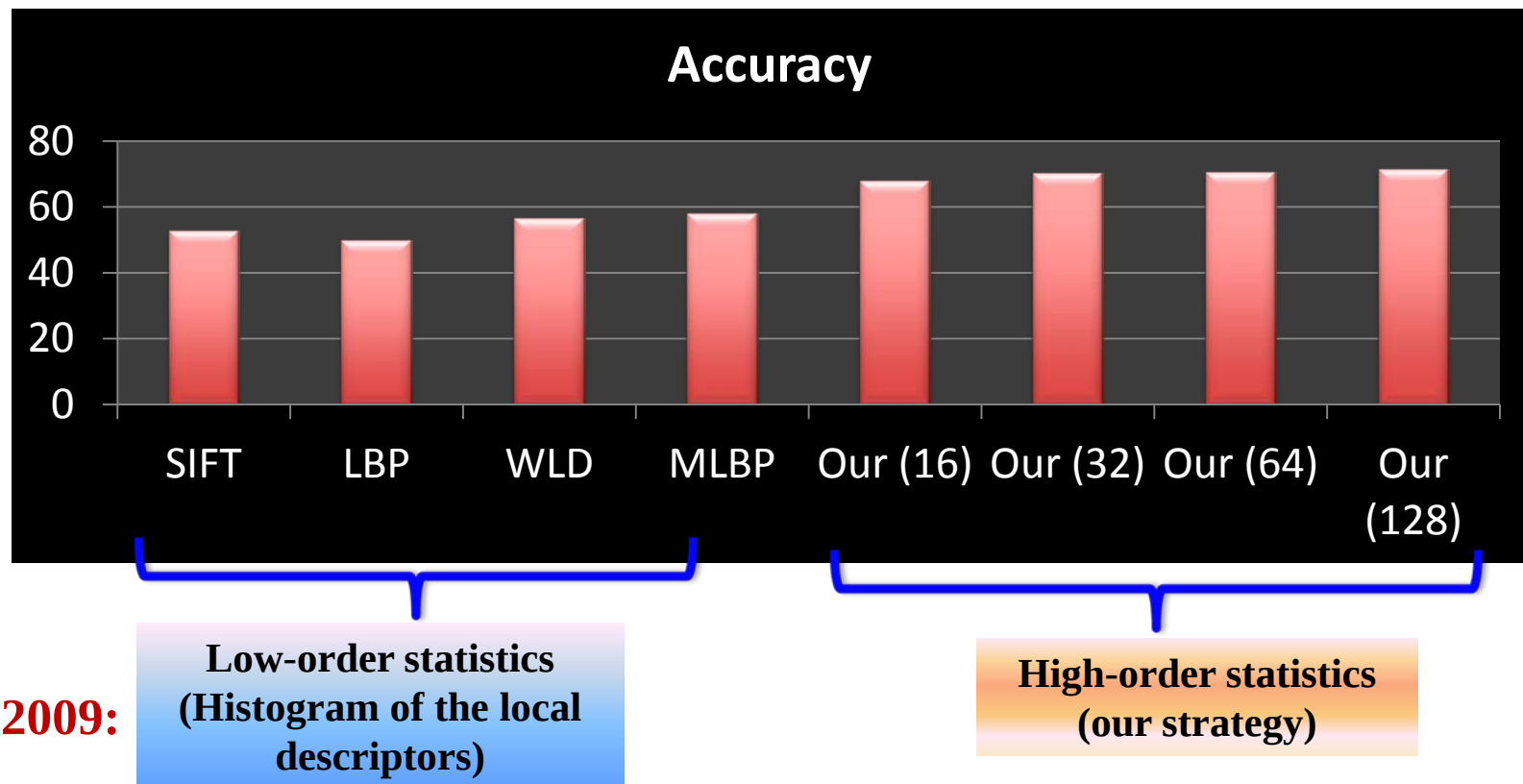
Average recognition rates of 3 runs

The recognition performance compared to the state-of-the-art methods



- (1) Classifier: linear SVM
- (2) Select the images of three instances for training, and the remainder one for test (same to the experimental setting in the state-of-the-art methods)

Average recognition rates of 4 runs



PAMI2009:

- **Proposed a simple, yet powerful local descriptor for local structure representation.**
- **Adaptively modeling the local descriptor space using a parametric probability process instead of quantization.**
- **Extract not only low-order statistics but also high-order statistics for image representation.**
- **Apply the proposed strategy to three image classification application, and prove the possible promising performance..**

Thank you for your attention!